



YD5010—Grating Spectrodensitometer

Under the 45/0 geometric optical illumination and the testing conditions of M O, M 1, M 2, M 3 stipulated by ISO 13655 standard, the instrument can accurately measure the reflectance data of samples. Under multiple color spaces, it can accurately measure various printing density indexes, color difference formulas and color indexes, and can meet the user's regular testing of various parameters.



Concave-Grating



LED light sources



High hardware configuration



Spectral USB



PRODUCT FEATURES

1. Perfect combination of the beautiful appearance and the ergonomic structure design;
2. Combined LED light sources with long life and low power consumption, including UV light;
3. Switchable apertures: $\Phi 2/4/8/20\text{mm}$, adapt to more samples;
4. Accurately measure reflectance spectrum, CMYK density and Lab value of the sample;
5. High-configuration electronic hardware: 3.5-inch TFT true-color screen, capacitive touch screen, concave grating, 256-pixel dual-array CMOS image sensor, etc;
6. Two standard observer angles: 2/10, multiple light source modes and color systems;
7. USB mode is widely useful;
8. Large-capacity storage space, over 10,000 test data;
9. Especially suitable for process control and quality control of printing plants;
10. PC software has powerful function expansion.



APPLICATION INDUSTRY

It is widely used in ink, printing, film processing, textile dyeing, plastic electronics and other industries for accurate color measurement and quality control, as well as in scientific research institutions, quality testing institutions, laboratories; especially suitable for precise measurement and quality control of optical density and dot enlargement in ink printing.



Ink & *Printing



Paper



Textile



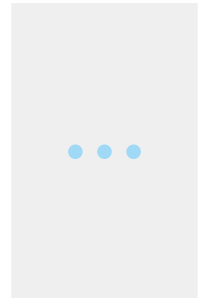
Automobile



Plastics



Laboratory



Other

TECHNICAL SPECIFICATIONS

Model: YD5010

Illumination: 45/0

Standard: ISO 5-4, CIE No. 15

Light Source: Combined LED source, UV light

Spectral mode: Concave-Grating

Sensor: 256-pixel dual-array CMOS image sensor,

Wavelength range: 400~700nm

Wavelength pitch: 10nm

Half bandwidth: 10nm

Measurement conditions: meet the ISO 13655 measurement conditions: M0 (CIE light source A); M1 (CIE light source D50) M2 (excluding UV illumination); M3 (M2 + polarized light filter)

Density standard: ISO Status T、E、A、I

Density index: density value, density difference, dot area, dot increase, overprint, printing characteristics, printing contrast, tone error and grayscale

Measurement Aperture: $\Phi 2\text{mm}$ 、 $\Phi 4\text{mm}$ 、 $\Phi 8\text{mm}$

Color Space: CIE LAB, XYZ, Yxy, LCh

Color difference formula: ΔE^*ab

Other colorimetric indexes: WI (ASTM

E313, CIE/ISO, AATCC, Hunter), YI (ASTM D1925, ASTM 313), MI,

Cover Ratio

Observer Angle : 2°/10°

Illuminant: D65, A, C, D50, D55, D75

Measuring time: Approx. 1.5s

Repeatability: density value: within 0.01D

Chromaticity value: within ΔE^*ab 0.04

Inter-instrument agreement: within ΔE^*ab 0.2 (Average for 12 BCRA series II color tiles)

Measurement method: single measurement, average measurement (2-99 times)

Size: L*W*H 184X77X105mm

Weight: Approx. 600g

Battery life: lithium battery, 5000 times in 8 hours

Lighting source life: 5 years, more than 3 million measurements

Display screen: TFT true color 3.5 inch,

Touch Screen Interface: USB

Storage: 10000

Language: simplified Chinese, English, Traditional Chinese

Standard accessories: power adapter, data line, built-in lithium batteries, instructions, quality control software (+download from official website), black and white calibration board, protection cover, polarization filter box

Optional accessories: Micro printer

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